

Notice of References Cited	Application/Control No. 10/649,089	Applicant(s)/Patent Under Reexamination BYUN, JAE-CHUL	
	Examiner Brian E. Glessner	Art Unit 3635	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-1,987,826	01-1935	GUSTAV HEUMANN	403/73
	B	US-4,515,280	05-1985	Sheu, ROUNG-Hwang	211/189
	C	US-2004/0131416	07-2004	Wu et al.	403/170
	D	US-6,073,412	06-2000	Verch, John T.	52/656.5
	E	US-6,718,709	04-2004	Koutras et al.	52/285.1
	F	US-5,746,508	05-1998	Chin, Jr., Paul W.	362/367
	G	US-5,918,998	07-1999	Pourmand, Tooraj	403/218
	H	US-2003/0163969	09-2003	Silverman, Arthur	52/655.1
	I	US-6,390,719	05-2002	Chan, Shin Jung	403/205
	J	US-6,682,256	01-2004	Hor, Chiou-Pin	403/382
	K	US-5,450,701	09-1995	White, John P. S.	52/656.9
	L	US-4,502,260	03-1985	Machler, David C.	52/656.9
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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